

OptiMOS™-5 Power-Transistor





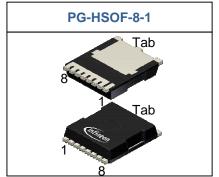
Features

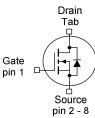
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- Ultra low Rds(on)
- 100% Avalanche tested

Туре	Package	Marking	
IAUT300N08S5N014	PG-HSOF-8-1	5N08014	

Product Summary

V_{DS}	80	V
R _{DS(on)}	1.4	mΩ
I _D	300	Α





Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10V ¹⁾	300	Α
		T _C =100 °C, V _{GS} =10 V ²⁾	230	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	1200	
Avalanche energy, single pulse ²⁾	E _{AS}	/ _D =150 A	600	mJ
Avalanche current, single pulse	IAS	-	300	А
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P_{tot}	T _C =25 °C	300	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics ²⁾						
Thermal resistance, junction - case	R_{thJC}	-	-	-	0.5	K/W

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage ²⁾	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	80	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 230 \mu {\rm A}$	2.2	3	3.8	
Zero gate voltage drain current ²⁾	I _{DSS}	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C	-	0.1	1	μA
		$V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =85 °C ²⁾	-	1	20	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =6 V, I _D =75 A	-	1.6	2.1	mΩ
		V _{GS} =10 V, I _D =100 A	-	1.1	1.4	



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	Ciss		-	10137	13178	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz	-	1626	2114	
Reverse transfer capacitance	C _{rss}		-	71	106	
Turn-on delay time	$t_{d(on)}$		-	25	-	ns
Rise time	t _r	V _{DD} =40 V, V _{GS} =10 V,	-	15	-	
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =100 A, $R_{\rm G}$ =3.5 Ω	-	52	-	
Fall time	t_{f}]	-	46	-	
Gate Charge Characteristics ²⁾ Gate to source charge	Q _{gs}	<u> </u>		46	60	nC
Gate to drain charge	Q _{gd}			30	47	-
Gate charge total	Q _q	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V	_	144	187	-
Gate plateau voltage	V _{plateau}		_	4.5	-	V
Reverse Diode	ı			ı		•
Diode continous forward current ²⁾	Is	- T _C =25 °C	-	-	300	А
Diode pulse current ²⁾	I _{S,pulse}	7 _C =23 C	-	-	1200	
Diode forward voltage	V_{SD}	V _{GS} =0 V, I _F =100 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time ²⁾	t _{rr}	V _R =40 V, I _F =50A,	-	83	-	ns
Reverse recovery charge ²⁾	Q _{rr}	di _F /dt=100 A/µs	-	156	-	nC

 $^{^{1)}}$ Current is limited by bondwire; with an $R_{\rm thJC}$ = 0.5 K/W the chip is able to carry 327A at 25°C.

²⁾ Defined by design. Not subject to production test.

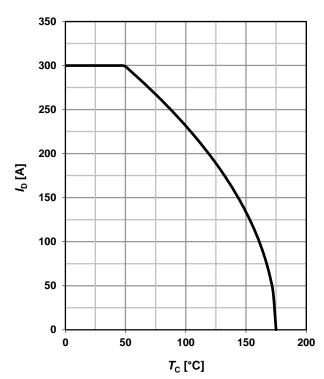


1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$



3 Safe operating area

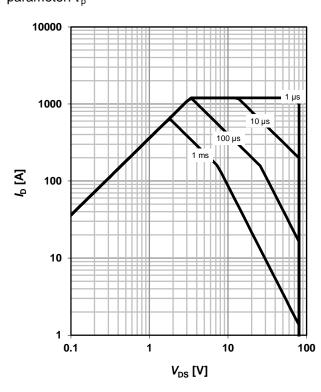
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

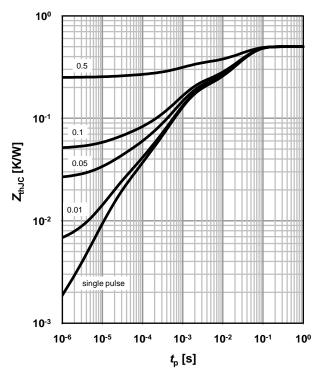
parameter: t_p

4 Max. transient thermal impedance

$$Z_{thJC} = f(t_p)$$

parameter: $D=t_p/T$



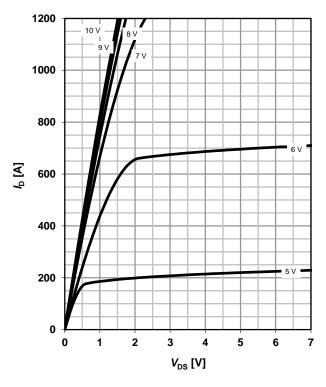




5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$

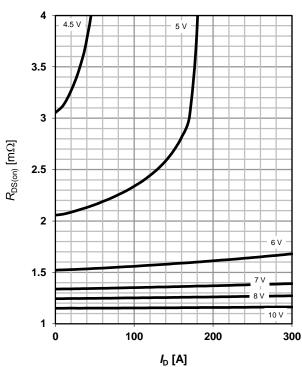
parameter: $V_{\rm GS}$



6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$

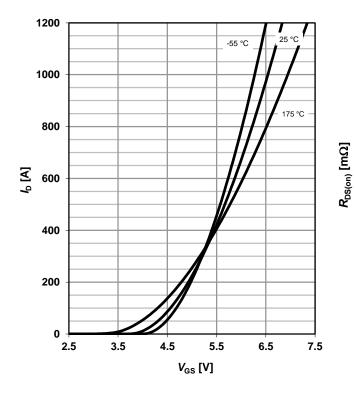
parameter: $V_{\rm GS}$



7 Typ. transfer characteristics

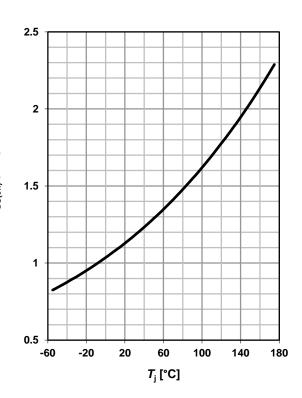
 $I_D = f(V_{GS}); V_{DS} = 6V$

parameter: T_i



8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$$





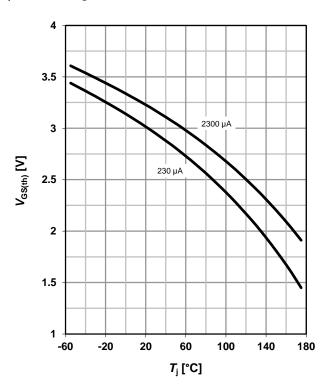
9 Typ. gate threshold voltage

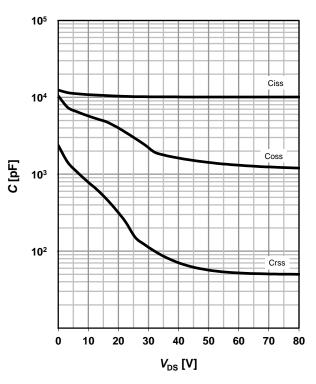
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D

10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$





11 Typical forward diode characteristics

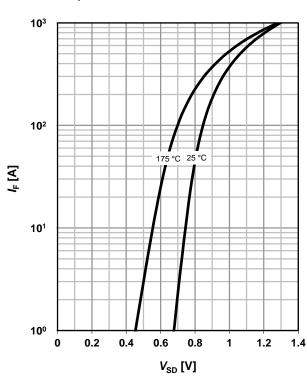
 $IF = f(V_{SD})$

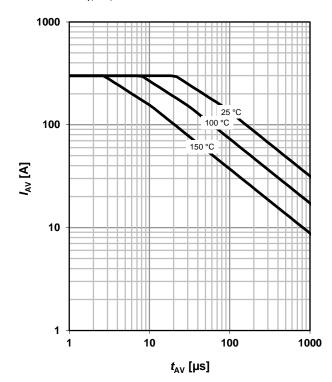
parameter: T_i

12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{j(start)}







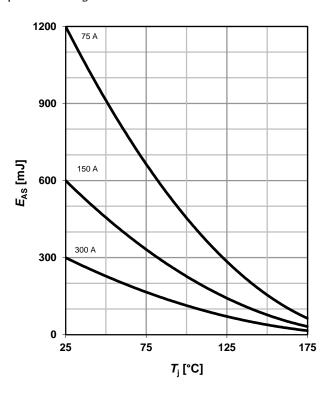
13 Typical avalanche energy

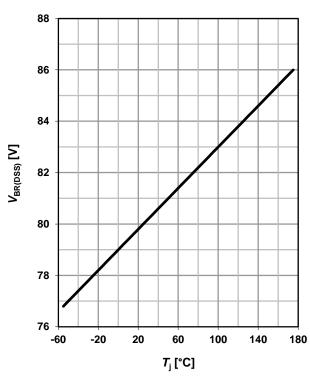
 $E_{AS} = f(T_i)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_{D_{typ}} = 1 \text{ mA}$$



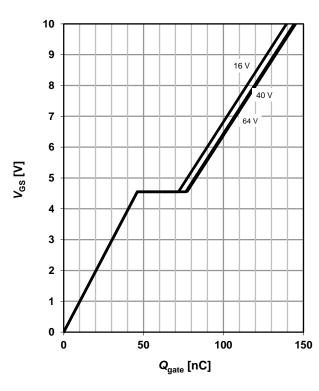


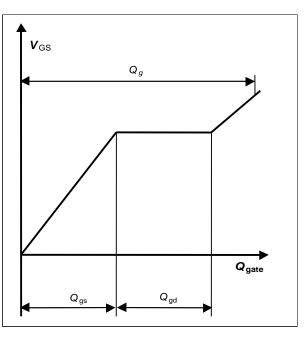
15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 100 A pulsed$

parameter: $V_{\rm DD}$









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Revision History

Version	Date	Changes
Version 1.0	15.12.2017	Final Data Sheet
Version 1.1	17.01.2024	package name (page 1)